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# **Truncation Error Study on Near Field Antenna Characteristics using Compressive Sensing**

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# 1 Cylindrical Measurement set-up

## 1.1 Fixed measurement step $\Delta_z^{\text{meas}} = 1 [\lambda]$ and different number of measurement points (M)

For the performed analysis:

- the measurement points are distributed in a cylindrical surface place at a radial distance  $\rho_{int} = \rho_{meas} = \rho = 5 [\lambda]$  away from the *AUT* which is placed along the  $z$ -axis;
- the employed *AUT* is characterized by a magnitude failure and phase shift affecting the 2<sup>nd</sup> row ( $\nu^{(2)} = 0.43$ ,  $\gamma^{(2)} = \frac{\pi}{3}$ ) and the considered failure ranges to build the over-complete basis are :  $\nu^{(s)} \in [0.0, 1.0]$ ,  $F^{(s)} = 7$  and  $\gamma^{(s)} \in [-\pi, \frac{\pi}{2}]$ ,  $P^{(s)} = 7$ . All the main parameters used for the simulations are listed below:

### Parameters

#### Gold Antenna (Without Defects)

- Geometry : Planar array of microstrip patches on the  $(x, y)$  plane;
- Working Frequency :  $f = 3.6 [\text{GHz}]$  ( $\lambda = 83.27 \times 10^{-3} [\text{m}]$  in free space);
- Substrate (PEC-backed) :
  - Dimensions : infinite;
  - Relative Permittivity :  $\varepsilon_{r,sub} = 4.7$ ;
  - Loss Tangent :  $\tan \delta_{sub} = 0.014$ ;
  - Thickness :  $h_{sub} = 0.019 [\lambda]$  (1.6 [mm]);
- Microstrip patches :
  - Dimensions :  $l_x \approx 0.22 [\lambda]$  (18.16 [mm]),  $l_y \approx 0.33 [\lambda]$  (27.25 [mm]);
  - Feeding : pin-fed;
- Spacing between elements :  $d_x = d_y = \frac{\lambda}{2}$ ;
- Number of elements in each row :  $N_y = 2$ ;
- Number of elements in each column :  $N_z = 6$ ;
- Total number of elements :  $N = (N_y \times N_z) = 12$ ;
- Total size of the antenna :  $L_y = 1 [\lambda]$ ,  $L_y = 3 [\lambda]$ ;
- Element excitations :  $w_n^{(s)} = 1.0 + j0.0$ ,  $n = 1, \dots, N^{(s)}$ ,  $s = 1, \dots, S$ ;

## Antenna Under Test (AUT - With Defects)

1. Failures of the excitation magnitude of the 2<sup>nd</sup> row;
  - Failure factor of the elements in the 2<sup>nd</sup> row ( $s = 2$ ) :  $\nu^{(2)} = 0.43$ ;
2. Failures of the excitation phase of the 2<sup>nd</sup> row;
  - Phase shift of the elements in the 2<sup>nd</sup> row ( $s = 2$ ) :  $\gamma^{(2)} = \frac{\pi}{3}$  [rad];

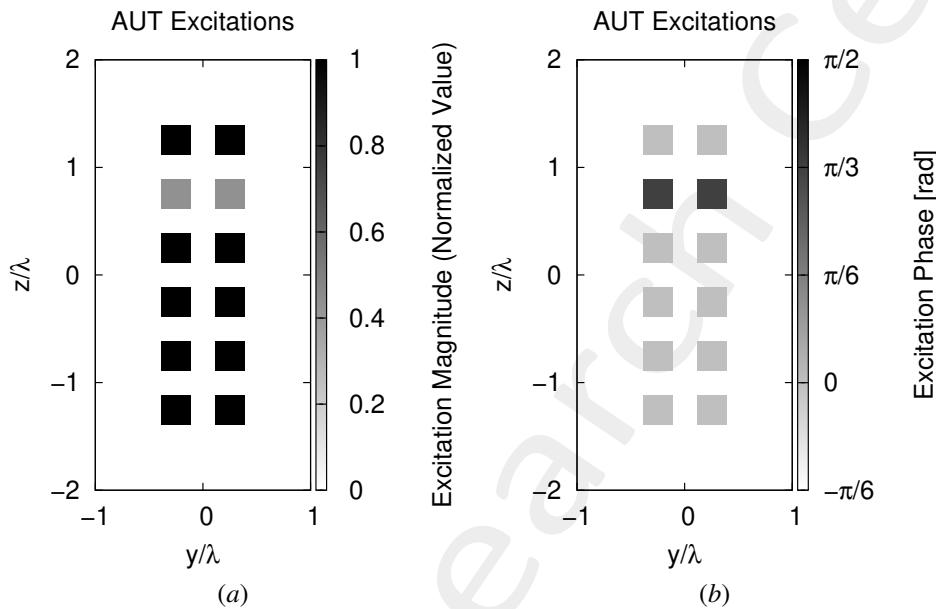


Figure 1: (a) Magnitude of the element excitations in the AUT ( $\nu^{(2)} = 0.43$ ), (b) phase of the element excitations in the AUT ( $\gamma^{(2)} = \frac{\pi}{3}$  [rad]).

## Measurement-by-Design Technique

- Number of generated bases :  $B = 12$ ;
- Bases  $b = 1, \dots, 6$  : magnitude failures in each row ( $s = 1, \dots, 6$ )
  - Failure factor of the elements :  $\nu^{(s)} \in [0.0, 1.0]$ ,  $s = 1, \dots, 6$ ;
  - Number of simulated failure factors :  $F^{(s)} = 7$ ,  $s = 1, \dots, 6$ ;
- Bases  $b = 7, \dots, 12$  : phase failures in each row ( $s = 1, \dots, 6$ )
  - Phase shift of the elements :  $\gamma^{(s)} \in [-\pi, \frac{\pi}{2}]$  [rad],  $s = 1, \dots, 6$ ;
  - Number of simulated phase shifts:  $P^{(s)} = 7$ ,  $s = 1, \dots, 6$ ;
- Threshold on the singular values magnitude (normalized) :  $\eta = -40$  [dB];
- Total number of simulated AUT configurations :  $K = S \times (F^{(s)} + P^{(s)}) = 6 \times (7 + 7) = 84$ ;

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## Dimension of the Over-Complete Basis

The dimension of the over-complete basis is

$$Q = 24$$

This number is given by the sum of the vectors belonging to the two considered bases:

1. Magnitude failures :  $Q_1, \dots, Q_6 = 2$ ;
2. Phase failures :  $Q_7, \dots, Q_{12} = 2$ .

## Alternative (BCS) MbD parameters

- Toleration factor for *BCS* solver:  $Tolerance = 1 \times 10^{-8}$ ;
- Initial noise variance for *BCS* solver:  $\eta_0^{opt} = 5 \times 10^{-4}$ . This values have been obtained as a result of a calibration procedure (see following Result section);

## Noise

- *SNR* on the measured data :  $SNR = \{50; 40; 30; 20; 10\} [dB]$ ;
- Noise seed : *Noise\_Seed* = 1.

## Measurement Set-Up (Cylindrical)

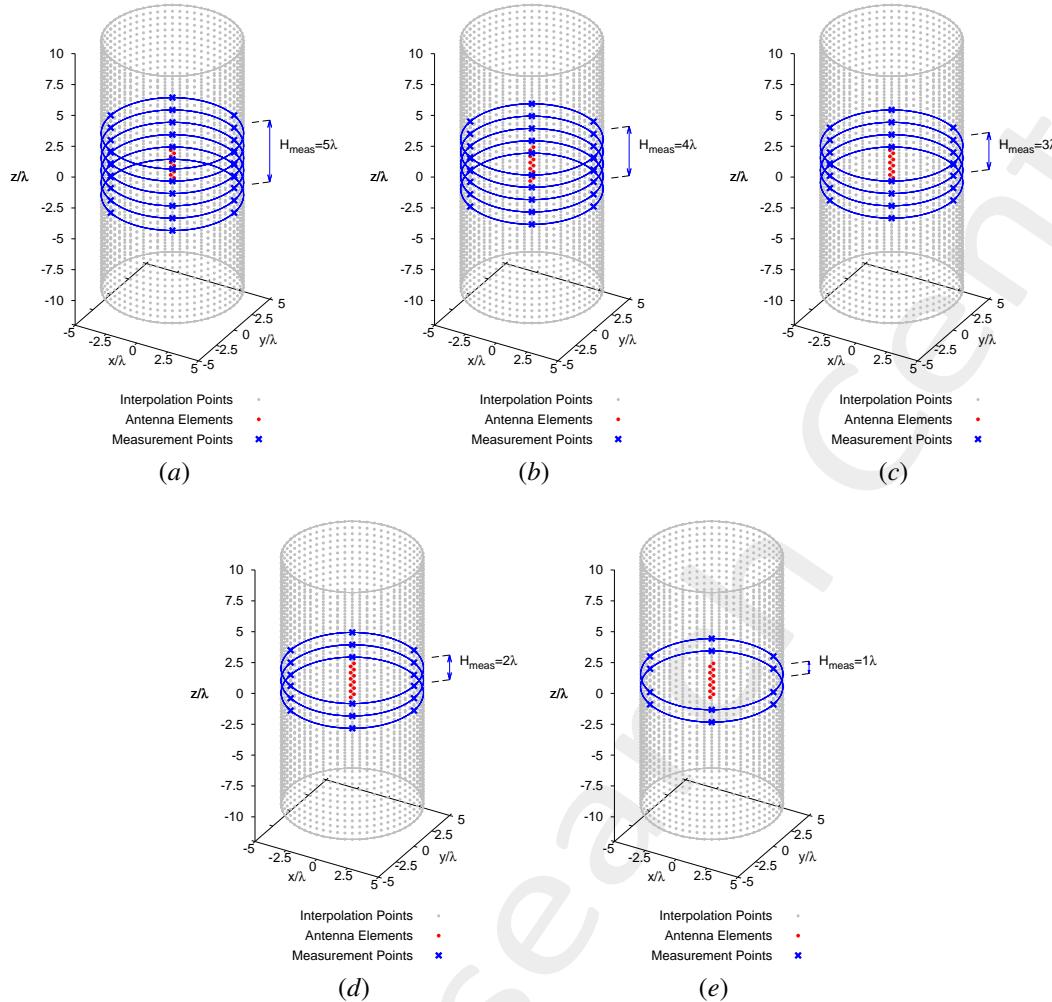


Figure 2: Disposition of the interpolation points ( $T = 2501$ ) and of the measurement points ( $M$ ) in the near-field region of the AUT.

- Type of measurements : near-field;
- Interpolation points :
  - Height of the interpolation region :  $H_{int} = 20 [\lambda]$ ;
  - Radius of the interpolation region :  $R = 5 [\lambda]$ ;
  - Number of points :  $T = (T_\varphi \times T_z) = (61 \times 41) = 2501$ ;
  - Coordinates :  $\rho_t \in R$ ,  $\varphi_t \in [-180, 180] [deg]$ ,  $z_t \in [-10, 10] [\lambda]$ ,  $t = 1, \dots, T$ ;
  - Interpolation step :  $\Delta_z^{int} = 0.5 [\lambda]$ ,  $\Delta_\varphi^{int} = 6 [deg]$ ;
- Measurement points :
  - Height of the measurement region :  $H_{meas} \in [1, 5] [\lambda]$ ;
  - Radius of the interpolation region :  $R = 5 [\lambda]$ ;
  - Number of points :  $M = (M_\varphi \times M_z)$ ;

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$H_{meas} [\lambda]$	$\Delta_z^{meas} [\lambda]$	$\Delta_\varphi^{meas} [deg]$	$M_z$	$M_\varphi$	$M$
1	1	60	2	6	12
2	1	60	3	6	18
3	1	60	4	6	24
4	1	60	5	6	30
5	1	60	6	6	36

Table I: Measurement configurations.

## Results

### Calibration of the initial noise variance ( $\eta_0$ ) for BCS-MbD

In order to find the best value for the initial noise variance value ( $\eta_0^{opt}$ ), the *BCS* version of the *MbD* has been run considering the following parameter values :

- Measurement points :
  - Height of the measurement region :  $H_{meas} = 1 [\lambda]$ ;
  - Radius of the interpolation region :  $R = 5 [\lambda]$ ;
  - Number of points :  $M = (M_\varphi \times M_z) = (2 \times 6) = 12$ ;
- $\eta_0 = [10^{-9}, 5 \times 10^{-9}, 10^{-8}, 5 \times 10^{-8}, 10^{-7}, 5 \times 10^{-7}, 10^{-6}, 5 \times 10^{-6}, 10^{-5}, 5 \times 10^{-5}, 10^{-4}, 5 \times 10^{-4}, 10^{-3}, 5 \times 10^{-3}, 10^{-2}, 5 \times 10^{-2}, 10^{-1}, 5 \times 10^{-1}, 1, 5, 10]$ ;
- $SNR = [60, 50, 40, 30, 20]$ ;
- Noise seed :  $Noise\_Seed = 1$ .

The best value has been computed as the minimum mean near-field error over the considered  $SNR$  values for each  $\eta_0$ ; in formula:

$$\eta_0^{opt} = \min_{\eta_0^{(i)}} \left\{ \frac{\sum_{j=1}^{N_{SNR}} \Xi_{AUT, \eta_0^{(i)}}^{(j)}}{N_{SNR}} \right\} \quad (1)$$

where

- $\eta_0^i$  is the  $i - th$  considered  $\eta_0$  value;
- $\Xi_{AUT, \eta_0^{(i)}}^{(j)}$  is the near field error obtained considering the  $i - th$  value of  $\eta_0$  and the  $j - th$  value of  $SNR$ ;
- $N_{SNR}$  is the total number of considered  $SNR$  values.

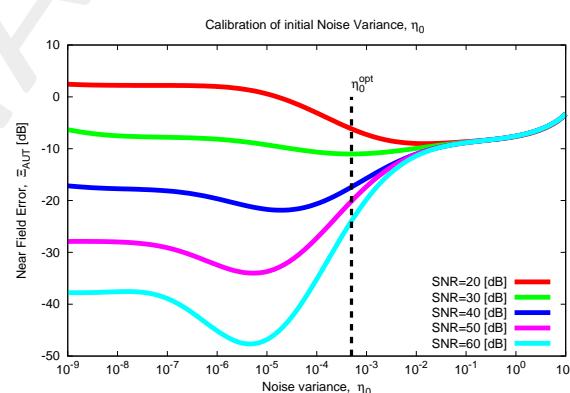


Figure 3: Initial noise variance  $\eta_0$  calibration considering  $H_{meas} = 1 [\lambda]$  and  $M = 16$ .

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The resulting optimum value for the initial noise variance is:

$$\eta_0^{\text{opt}} = 5 \times 10^{-4}.$$

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### 1.1.1 Height of the measurement region $H_{\text{meas}} = 5 [\lambda]$

#### Original (*OMP*) MbD parameters

- Max. number of iterations of the *OMP* algorithm :  $I = \{1; 2; 3; \dots; 10\}$ ;
- Selected iteration to report the results:  $I = 2$ ; this choice is justified by the fact that at this iteration the *OMP* algorithm reaches the best near field error as shown in the following Fig. 4.

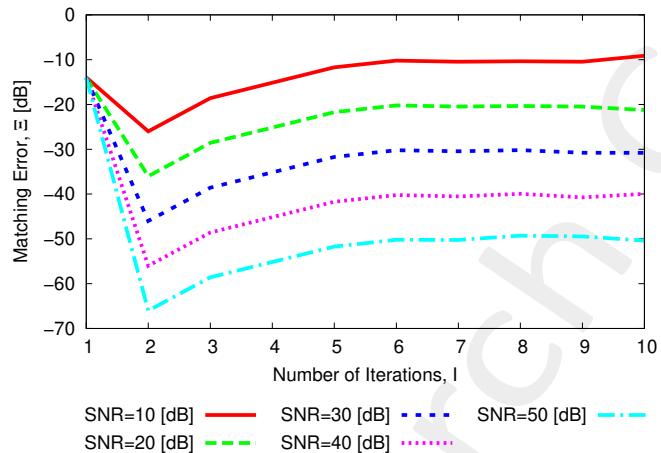


Figure 4: Behaviour of the near-field matching error versus the number of *OMP* iterations,  $I$ .

## Evaluation of the Truncation Error from Actual Near-Field Data

In order to evaluate the truncation error, in the following figure is presented a visual comparison of the near-field radiated by the *AUT* measured over the full interpolation region and on the truncated region, as well as the corresponding far-field patterns obtained with NF-FF transformation. The truncated near-field has been obtained as follows:

$$E_{tr}(\varphi, z) = \begin{cases} E(\varphi, z) & \text{if } -\frac{H_{meas}}{2} \leq z \leq \frac{H_{meas}}{2} \\ 0 & \text{otherwise} \end{cases}; \quad ; \quad -\frac{H_{int}}{2} \leq z \leq \frac{H_{int}}{2} \quad (2)$$

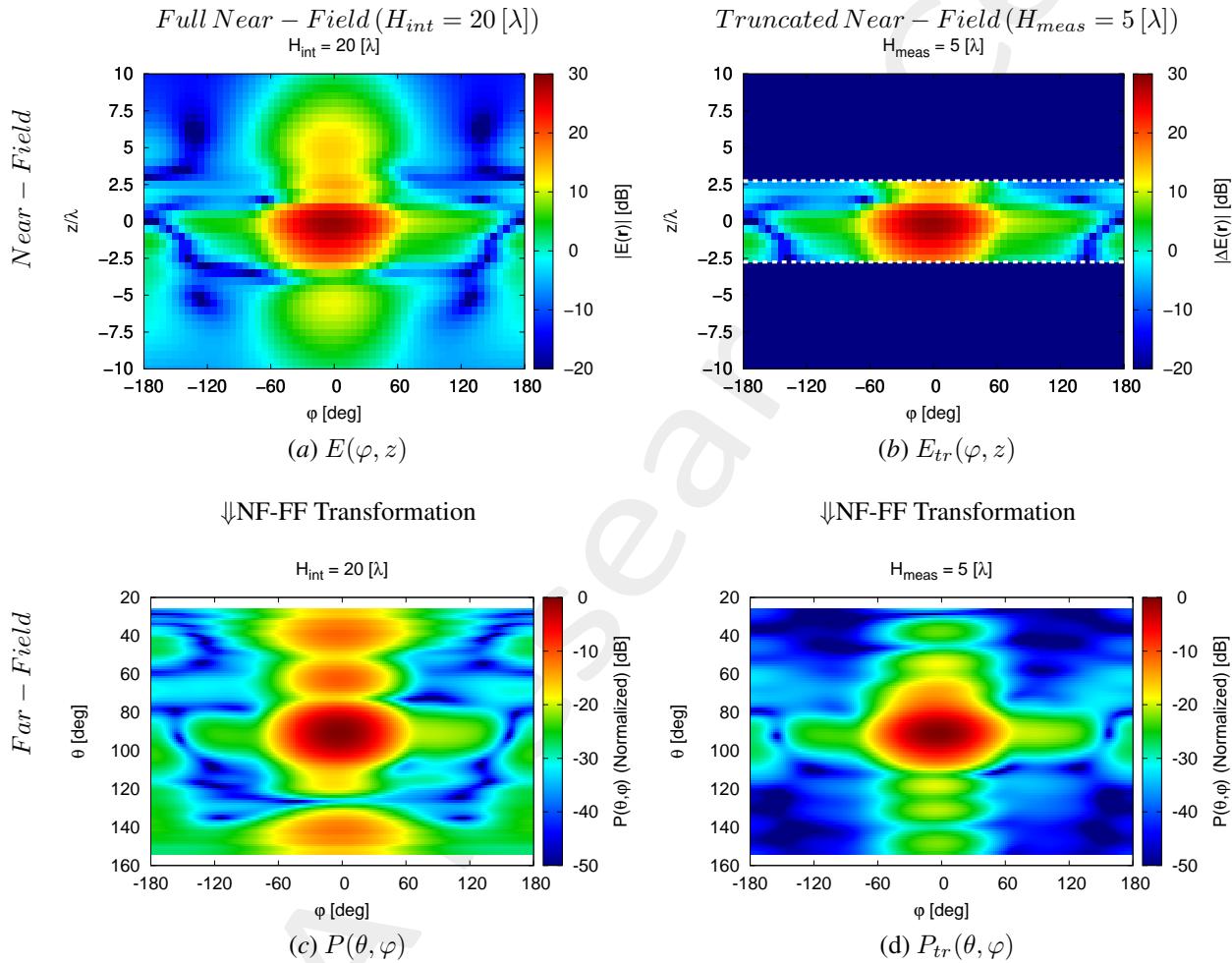


Figure 5:  $H_{meas} = 5 [\lambda]$  - (a)(b) Near-field and (c)(d) far-field patterns obtained via NF-FF transformation for the actual *AUT*.

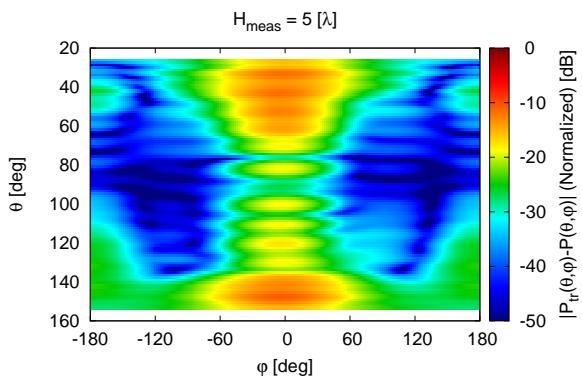


Figure 6:  $H_{meas} = 5 [\lambda]$  - Difference between the full and the truncated far-fields,  $|P(\theta, \varphi) - P_{tr}(\theta, \varphi)|$ .

## Near-Field Error

The comparison, in terms of near field error, between the original (*OMP*) and the alternative (*BCS*) MbD is reported in the following Fig. 7:

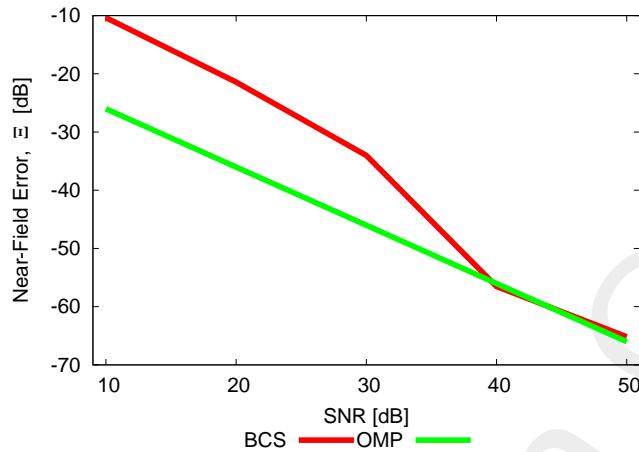


Figure 7: Near Field Error comparison between original (*OMP*) and alternative (*BCS*) MbD for different *SNR* values

SNR [dB]	Near Field Error, $\Xi$ [dB]	
	BCS	OMP
50	-65.18	-66.01
40	-56.53	-56.01
30	-34.03	-46.01
20	-21.43	-36.01
10	-10.35	-26.01

Table II: Near Field Errors obtained by the original (*OMP*) and alternative (*BCS*) MbD

## Observations

By observing the reported results it is possible to point out that the *OMP* algorithm outperforms the other one almost all over the entire range of *SNR* values. In particular:

- the *OMP* obtains satisfactory results already at  $SNR = 10$  [dB] where  $\Xi < -25$  [dB] and then its error decreases linearly with the increase of the *SNR*;
- the *BCS* results start to be good at  $SNR = 30$  [dB] since the error goes below  $-25$  [dB]; moving from  $SNR = 30$  [dB] to  $SNR = 40$  [dB] there is a remarkable result improvement and then the performance continue to enhance with the increase of the *SNR* so that for  $SNR \geq 40$  [dB] the *BCS* results are comparable to those of the *OMP*.

## Estimated Near-Field

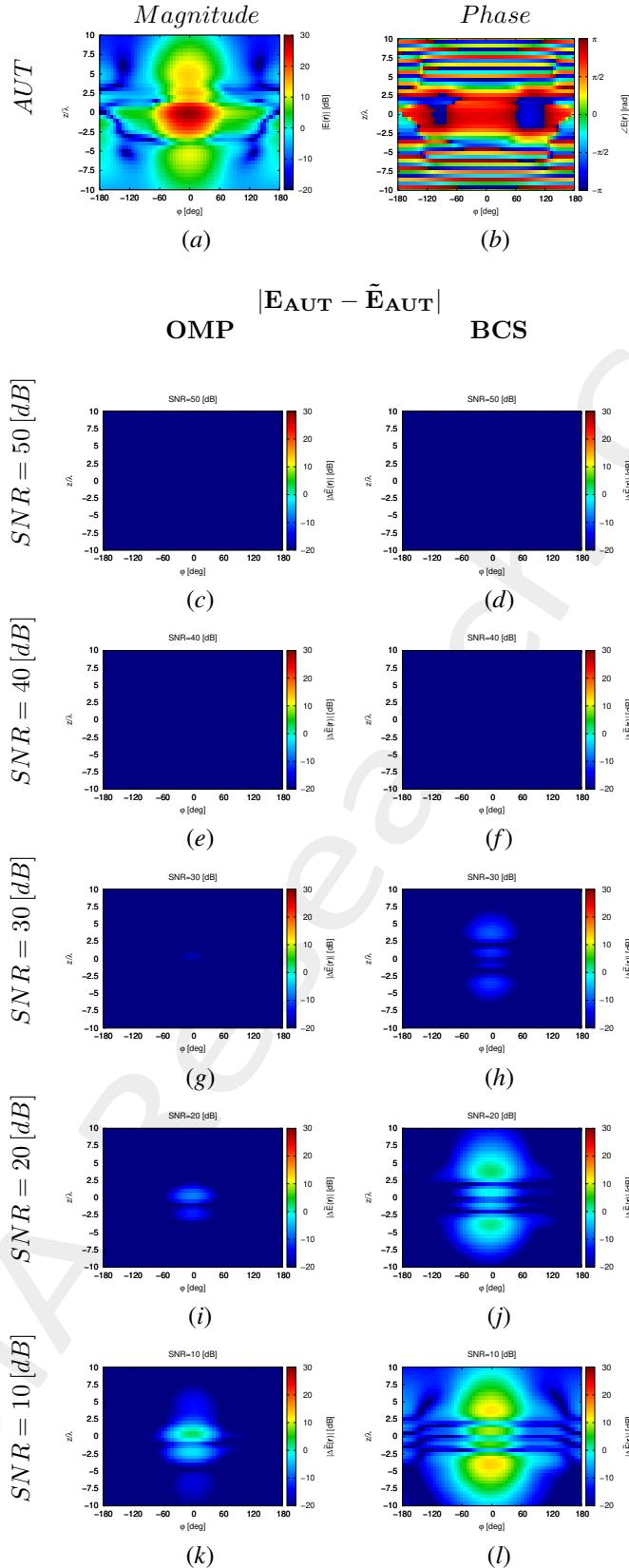


Figure 8: Magnitude difference between the actual and estimated 2 – D near-field pattern when processing noisy measurements at different  $SNRs$ .

## Estimated Far-Field

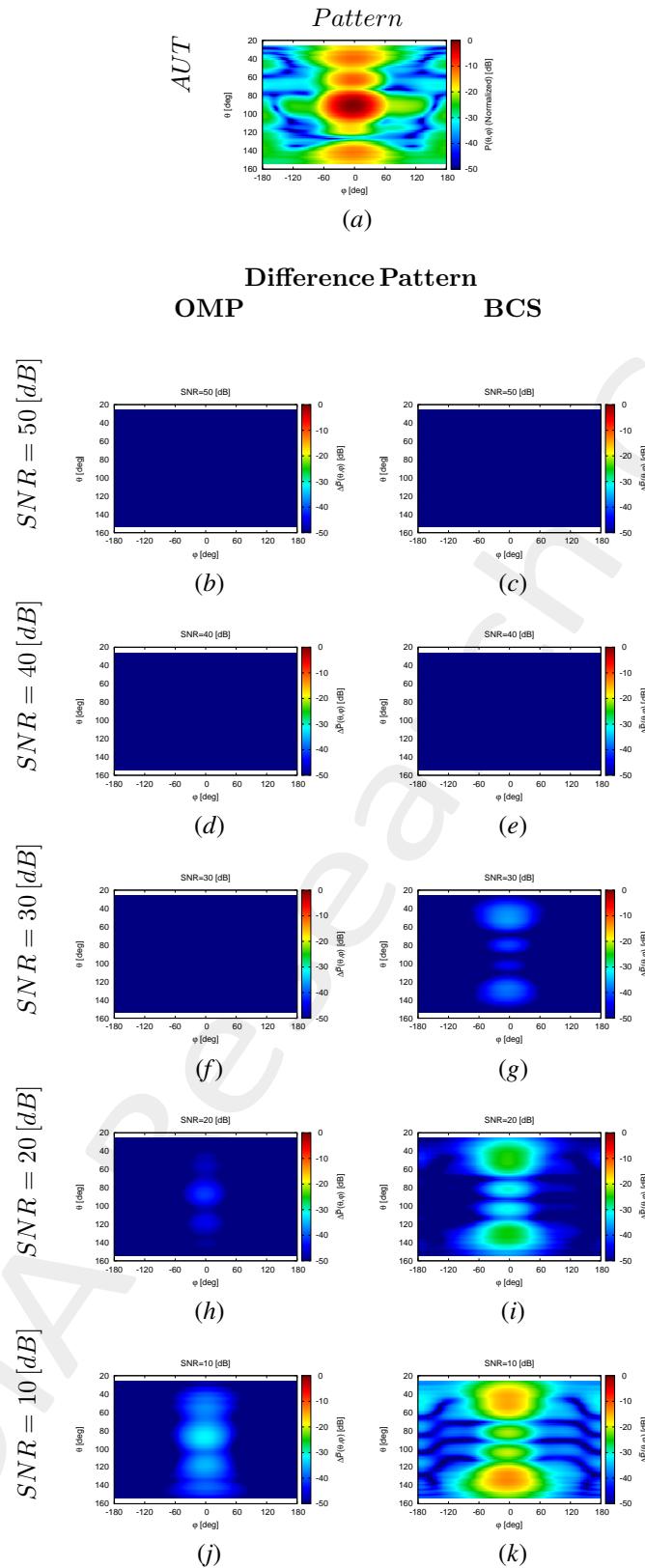


Figure 9: Difference between the actual and estimated 2 – D far-field pattern when processing noisy measurements at different SNRs.

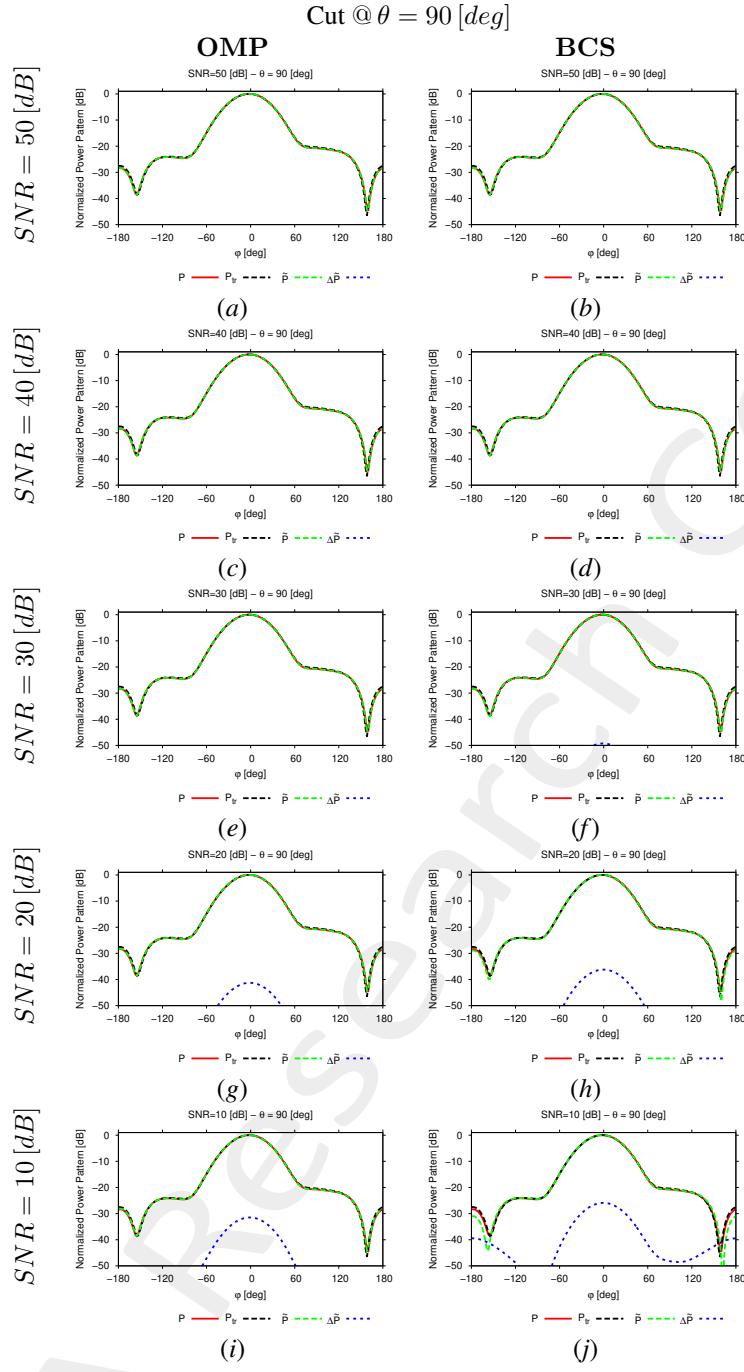


Figure 10:  $1 - D$  cuts of the estimated far-field pattern (obtained through near-to-far-field transformation from the estimated near-field patterns) under several noisy conditions

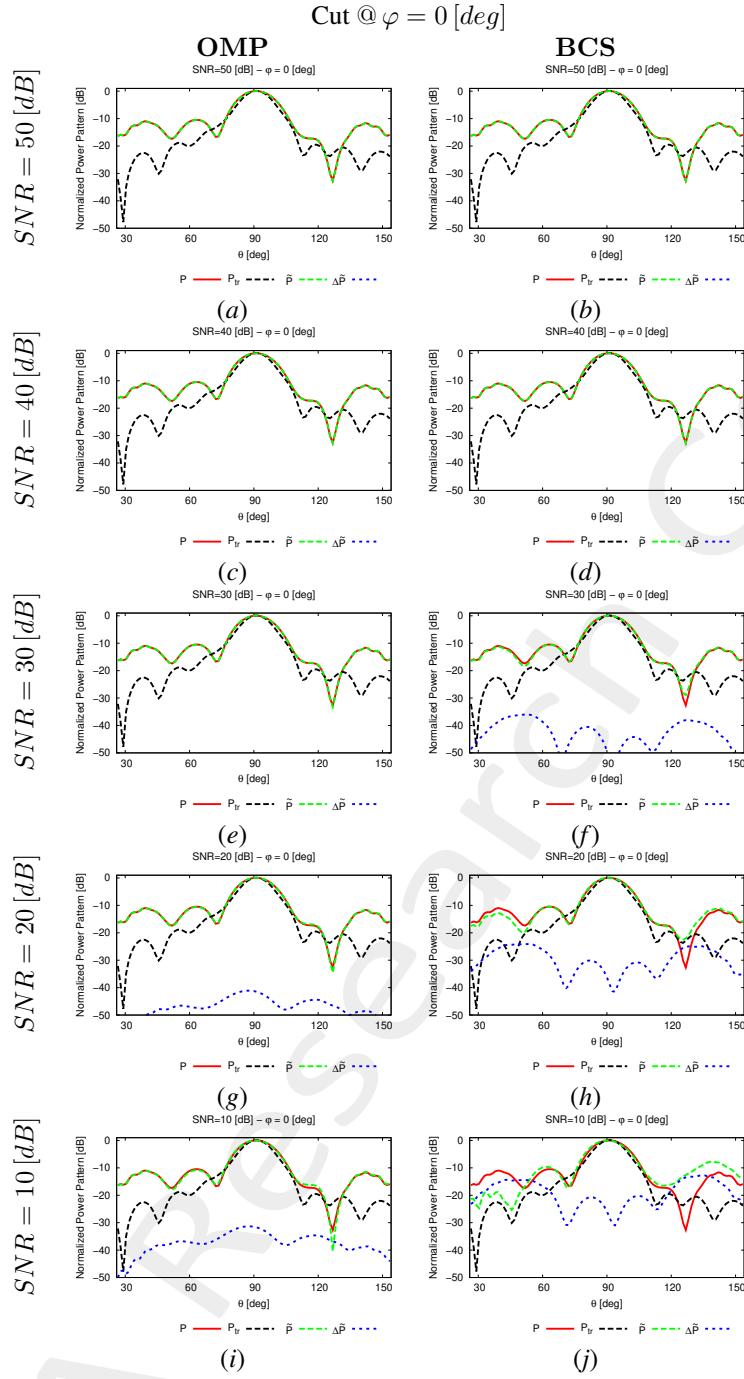


Figure 11: 1 – D cuts of the estimated far-field pattern (obtained through near-to-far-field transformation from the estimated near-field patterns) under several noisy conditions

SNR [dB]	Far – Field Error, $\chi$ [dB]	
	BCS	OMP
50	-64.61	-67.58
40	-58.51	-57.62
30	-31.02	-47.65
20	-18.00	-37.71
10	-6.81	-27.92

Table III: Far-field matching error between the actual and estimated AUT patterns (both obtained through near-to-far-field transformation from the corresponding near-field patterns) under several noisy conditions.

## Estimated Coefficients

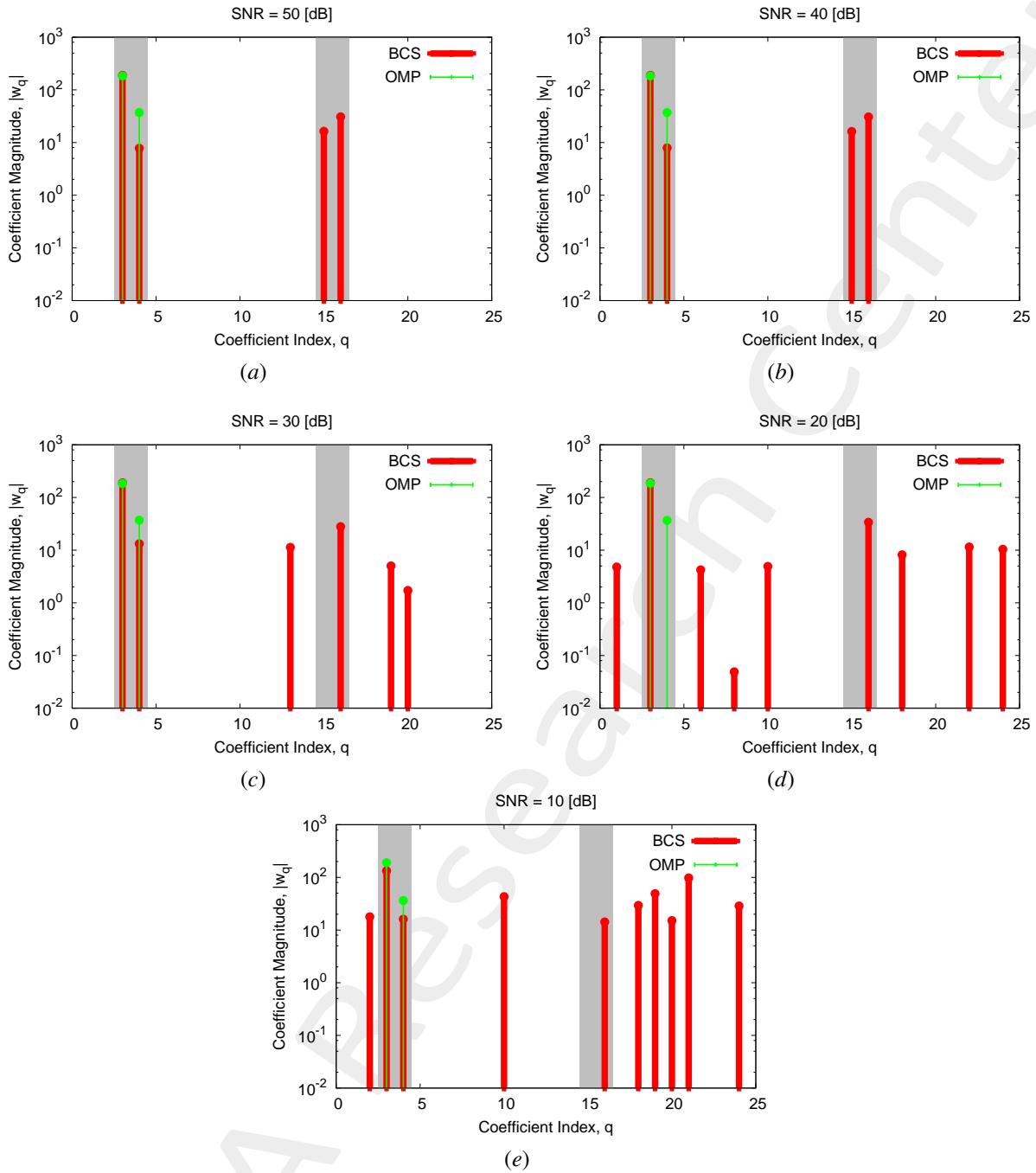


Figure 12: Coefficient comparison between original (*OMP*) and alternative (*BCS*) MbD : (a)  $SNR = 50 [dB]$ , (b)  $SNR = 40 [dB]$ , (c)  $SNR = 30 [dB]$ , (d)  $SNR = 20 [dB]$ , (e)  $SNR = 10 [dB]$

## Observations

The considered *AUT* is characterized by an excitation magnitude and phase of the second subarray (i.e.,  $\nu^{(2)} = 0.43$  and  $\gamma^{(2)} = \frac{\pi}{3} [\text{rad}]$ ):

- the *OMP* selects always the same two vectors corresponding to the magnitude failure actually affecting the *AUT* and none of those associated to the phase failure;
  - the *BCS* algorithm is able to identify both the failures affecting the *AUT* even if the failure detections, at  $10 [dB] \leq SNR \leq 30 [dB]$ , are not precise since the method selects also vectors not connected to the actual failures and it

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doesn't pick all the vectors of the failures affecting the *AUT*. For  $SNR \geq 40$  [dB] the BCS precisely selects all the basis functions associated to the failures affecting the *AUT*.

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## Computational times

- $\Delta t_{Sim}$ : Time required to simulate the  $K$  AUT configurations used to build the  $(T \times K)$  "pattern matrix";
- $\Delta t_{SVD}$ : Time required to perform the SVD of the  $(T \times K)$  "pattern matrix";
- $\Delta t_{MbE}^{OMP/BCS}$ : (Mean) Time required by the Measurement-by-Example tool to read the SVD output and perform the estimation of the AUT radiated field.

$\Delta t_{Sim}$ [sec]	$4.72 \times 10^4$
$\Delta t_{SVD}$ [sec]	$1.79 \times 10^2$
$\Delta t_{MbE}^{BCS}$ [sec]	$2.67 \times 10^{-1}$
$\Delta t_{MbE}^{OMP}$ [sec]	$1.93 \times 10^{-3}$

Table IV: Computational times

## Remarks

- Given that the number of simulated AUTs is  $K = S \times (F^{(s)} + P^{(s)}) = 84$ , the average per-AUT simulation time is

$$\Delta t_{FEKO} \simeq \frac{\Delta t_{Sim}}{K} = \frac{4.72 \times 10^4}{84} [\text{sec}] = 5.62 \times 10^2 [\text{sec}]$$

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### 1.1.2 Height of the measurement region $H_{\text{meas}} = 4 [\lambda]$

#### Original (*OMP*) MbD parameters

- Max. number of iterations of the *OMP* algorithm :  $I = \{1; 2; 3; \dots; 10\}$ ;
- Selected iteration to report the results:  $I = 3$ ; this choice is justified by the fact that at this iteration the *OMP* algorithm reaches the best near field error as shown in the following Fig. 13.

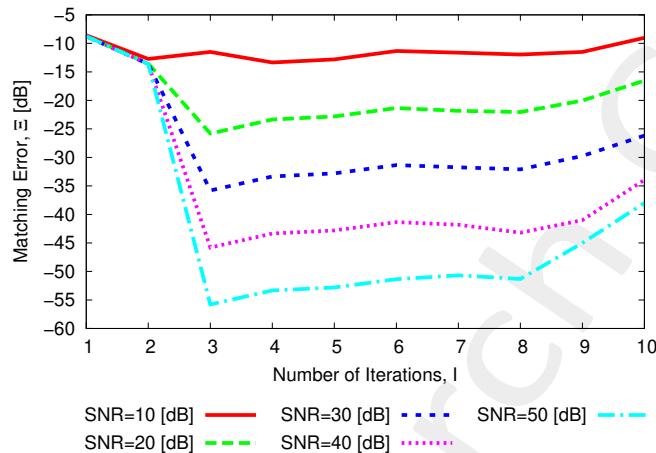


Figure 13: Behaviour of the near-field matching error versus the number of *OMP* iterations,  $I$ .

## Evaluation of the Truncation Error from Actual Near-Field Data

In order to evaluate the truncation error, in the following figure is presented a visual comparison of the near-field radiated by the *AUT* measured over the full interpolation region and on the truncated region, as well as the corresponding far-field patterns obtained with NF-FF transformation. The truncated near-field has been obtained as follows:

$$E_{tr}(\varphi, z) = \begin{cases} E(\varphi, z) & \text{if } -\frac{H_{meas}}{2} \leq z \leq \frac{H_{meas}}{2} \\ 0 & \text{otherwise} \end{cases}; \quad ; \quad -\frac{H_{int}}{2} \leq z \leq \frac{H_{int}}{2}$$

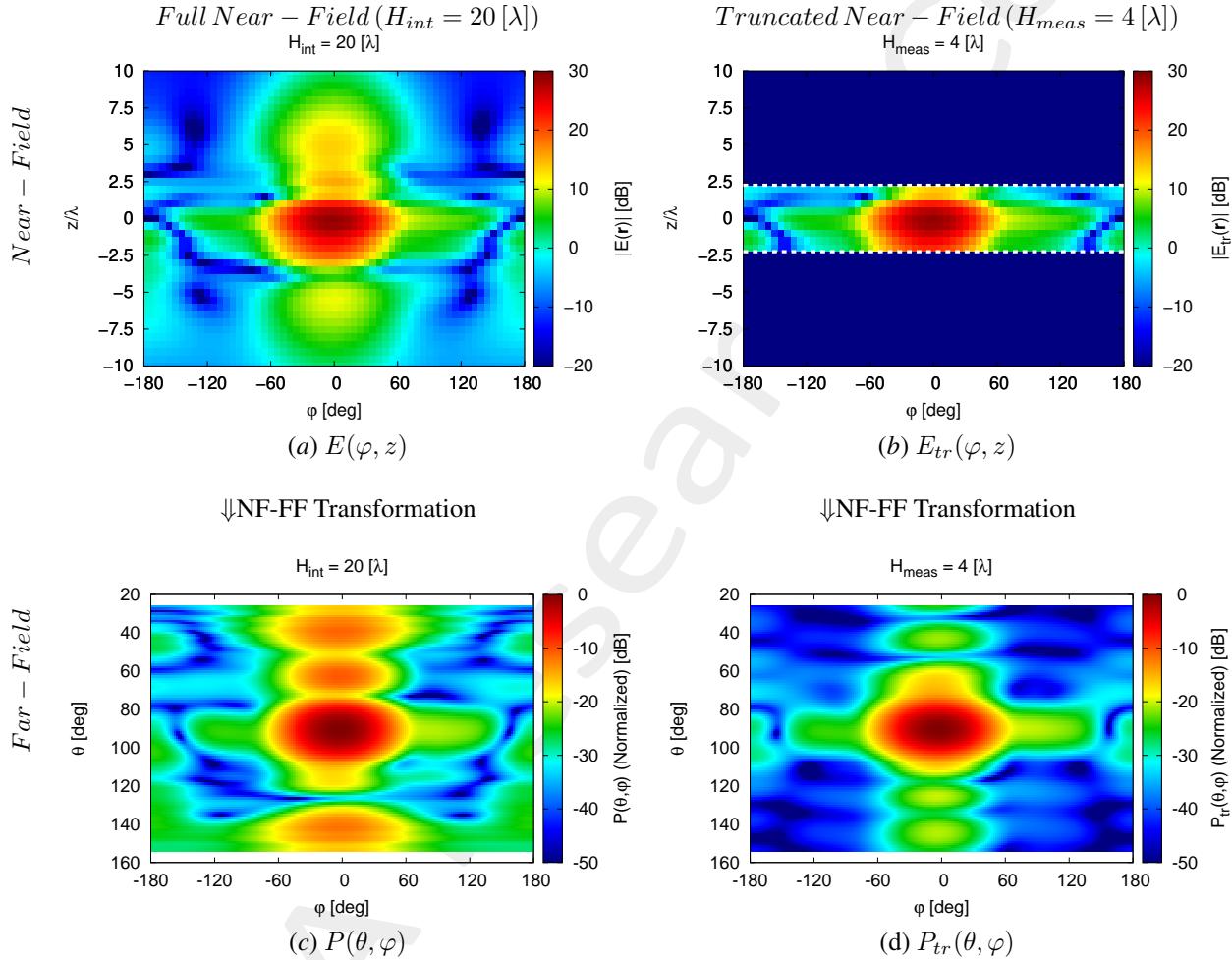


Figure 14:  $H_{meas} = 4 [\lambda]$  - (a)(b) Near-field and (c)(d) far-field patterns obtained via NF-FF transformation for the actual *AUT*.

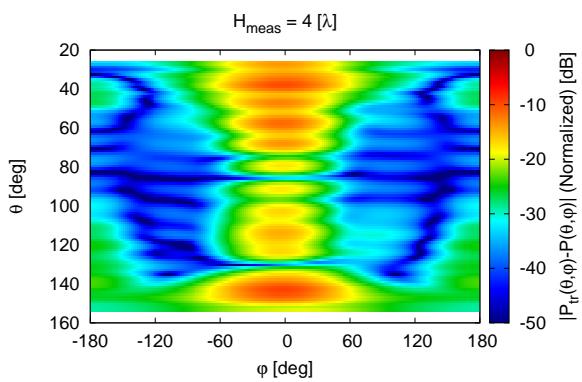


Figure 15:  $H_{meas} = 4 [\lambda]$  - Difference between the full and the truncated far-fields,  $|P(\theta, \varphi) - P_{tr}(\theta, \varphi)|$ .

## Near-Field Error

The comparison, in terms of near field error, between the original (*OMP*) and the alternative (*BCS*) MbD is reported in the following Fig. 16:

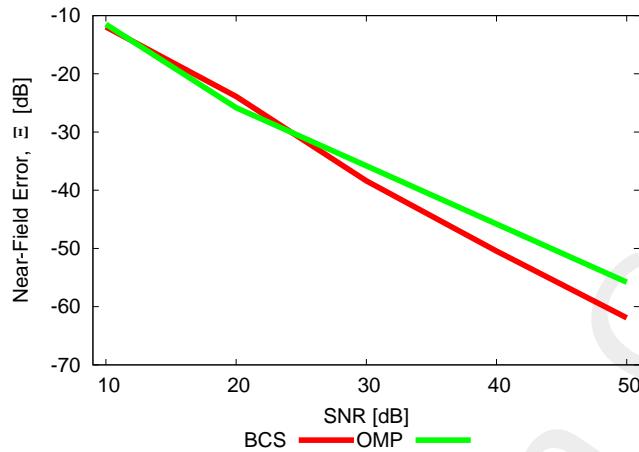


Figure 16: Near Field Error comparison between original (*OMP*) and alternative (*BCS*) MbD for different *SNR* values

SNR [dB]	Near Field Error, $\Xi$ [dB]	
	BCS	OMP
50	-61.91	-55.79
40	-50.45	-45.80
30	-38.39	-35.80
20	-23.90	-25.81
10	-11.94	-11.49

Table V: Near Field Errors obtained by the original (*OMP*) and alternative (*BCS*) MbD

## Observations

By observing the reported results it is possible to point out that :

- the *OMP* error decreases linearly with the increase of the *SNR* reaching good performance ( $\Xi \leq -25$  [dB]) starting from *SNR* = 20 [dB];
- the *BCS* results are not good until for *SNR* < 30 [dB] but similar to those of the *OMP*; however, starting from *SNR* = 30 [dB] the *BCS* reaches lower errors than the *OMP* ones.

## Estimated Near-Field

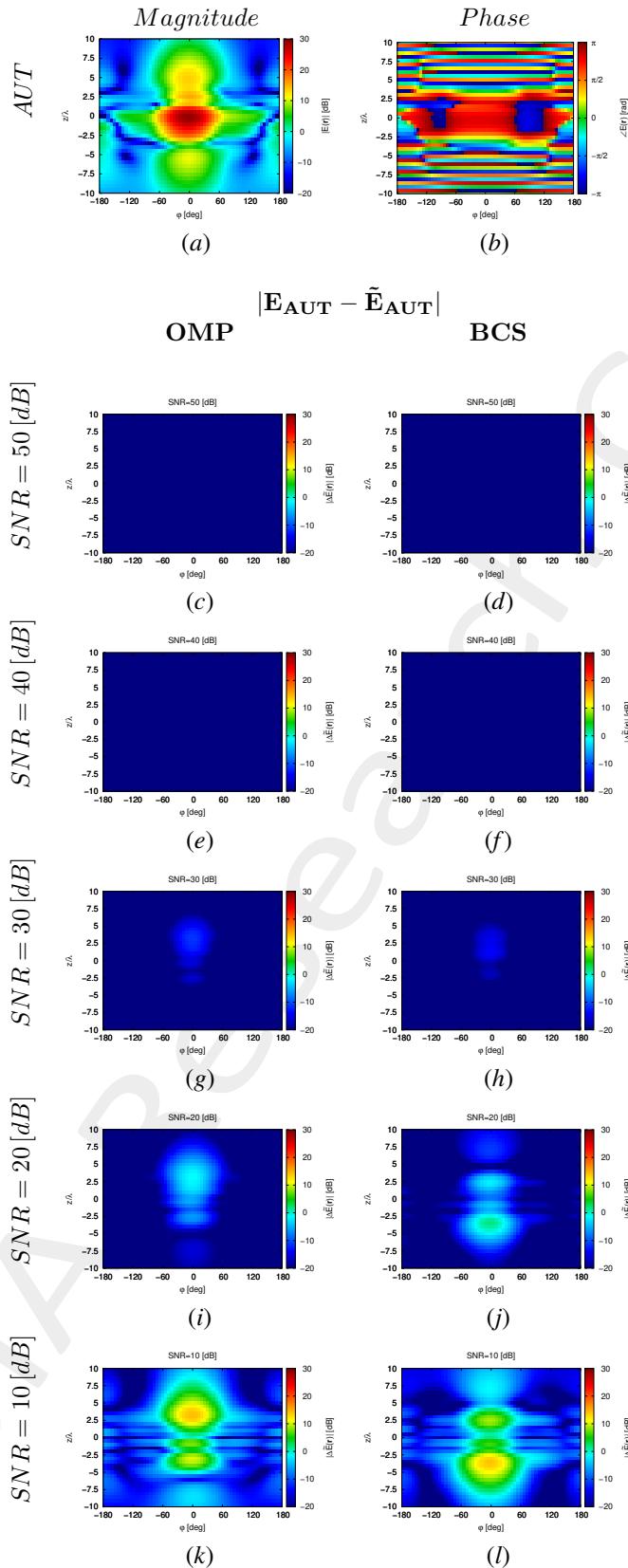


Figure 17: Magnitude difference between the actual and estimated 2 – D near-field pattern when processing noisy measurements at different  $SNRs$ .

## Estimated Far-Field

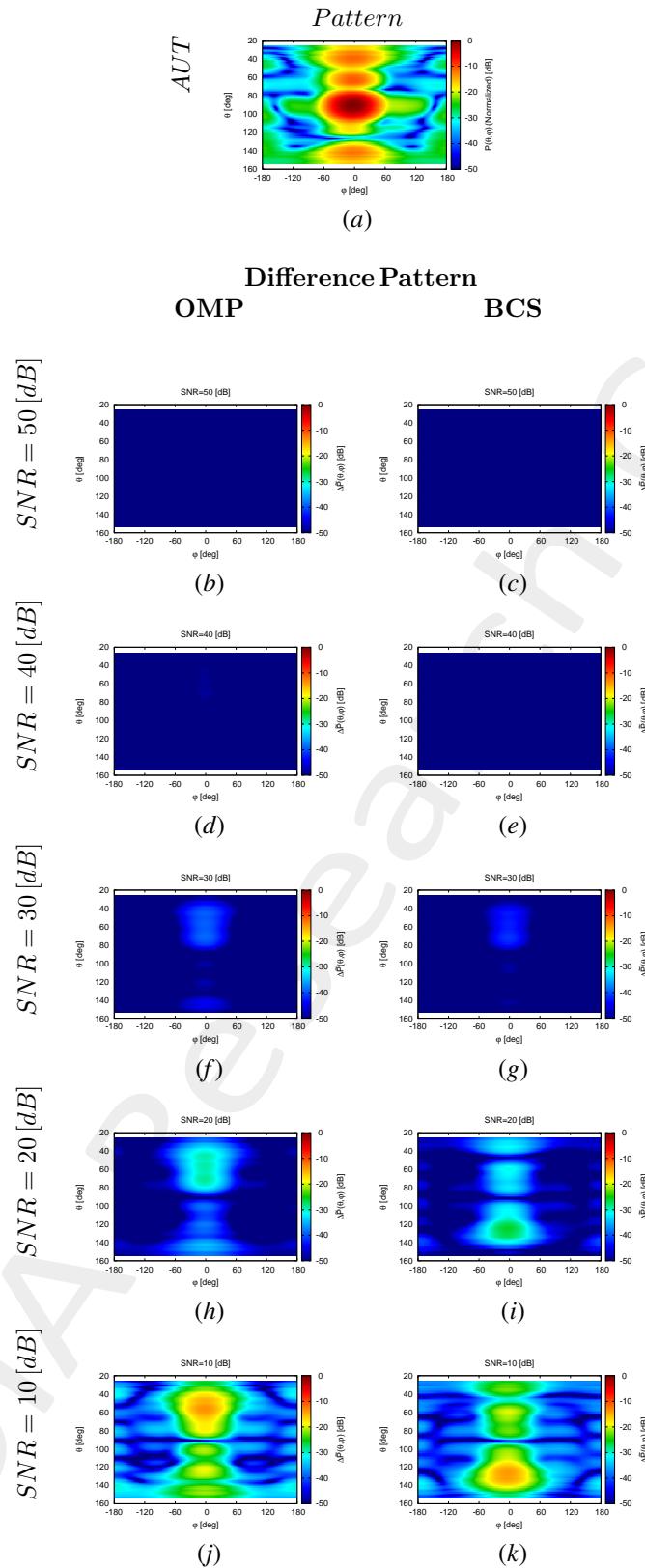


Figure 18: Difference between the actual and estimated 2 – D far-field pattern when processing noisy measurements at different SNRs.

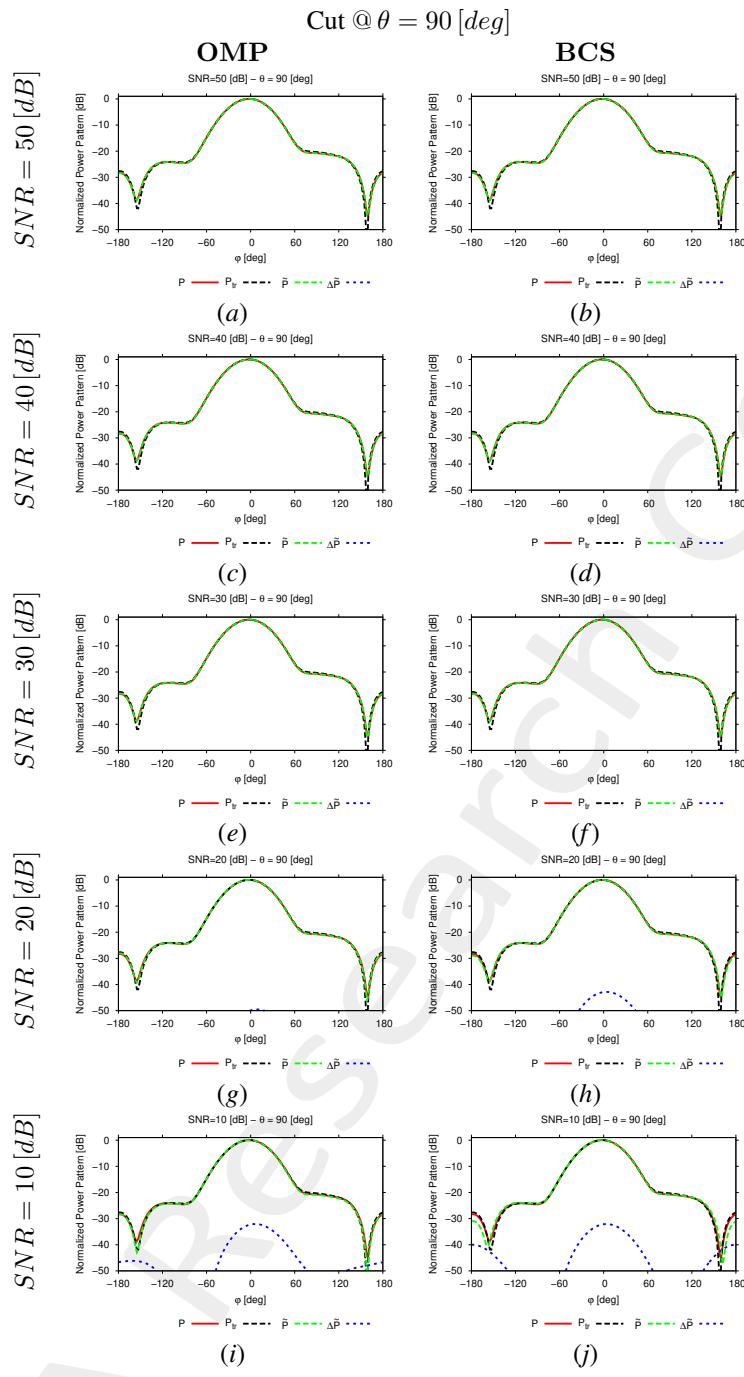


Figure 19: 1 –  $D$  cuts of the estimated far-field pattern (obtained through near-to-far-field transformation from the estimated near-field patterns) under several noisy conditions

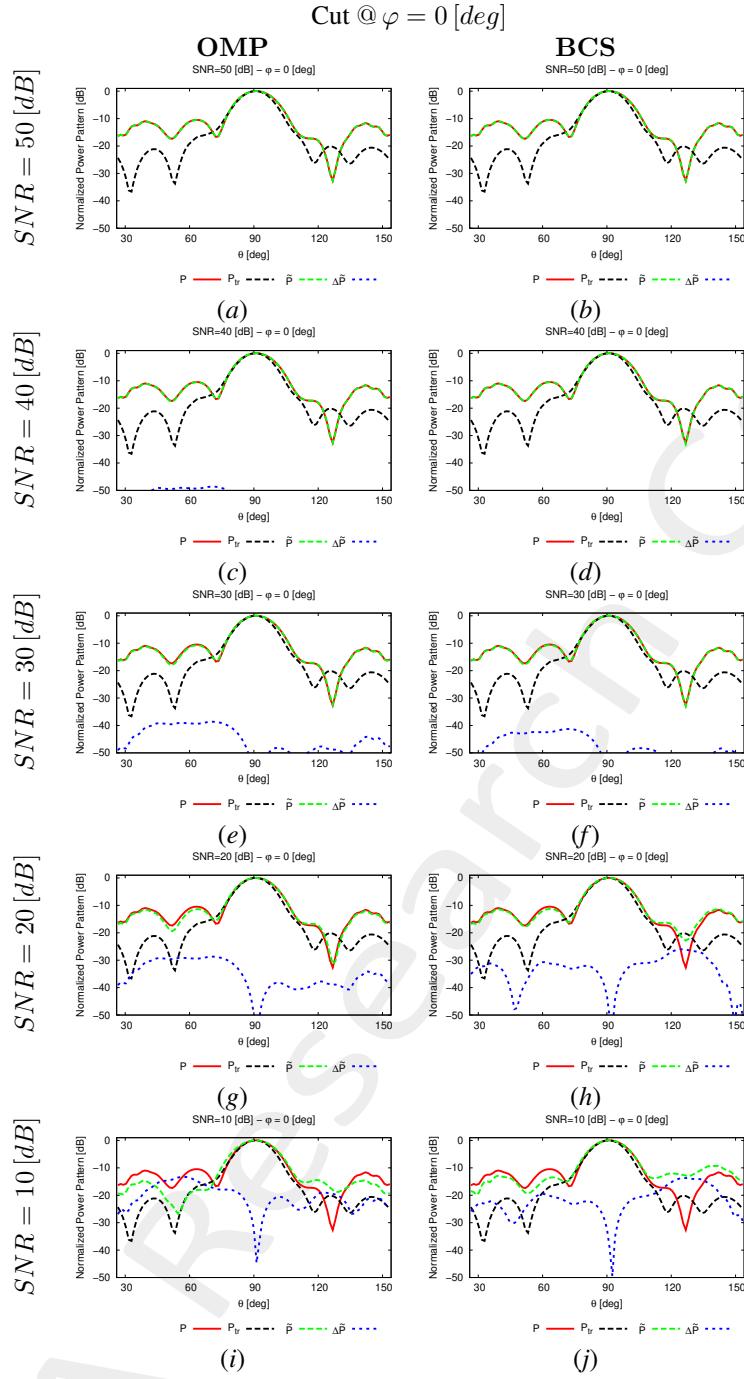


Figure 20:  $1 - D$  cuts of the estimated far-field pattern (obtained through near-to-far-field transformation from the estimated near-field patterns) under several noisy conditions

SNR [dB]	Far - Field Error, $\chi$ [dB]	
	BCS	OMP
50	-60.59	-55.79
40	-49.10	-45.80
30	-36.58	-35.80
20	-21.79	-25.81
10	-9.88	-11.49

Table VI: Far-field matching error between the actual and estimated AUT patterns (both obtained through near-to-far-field transformation from the corresponding near-field patterns) under several noisy conditions.

## Estimated Coefficients

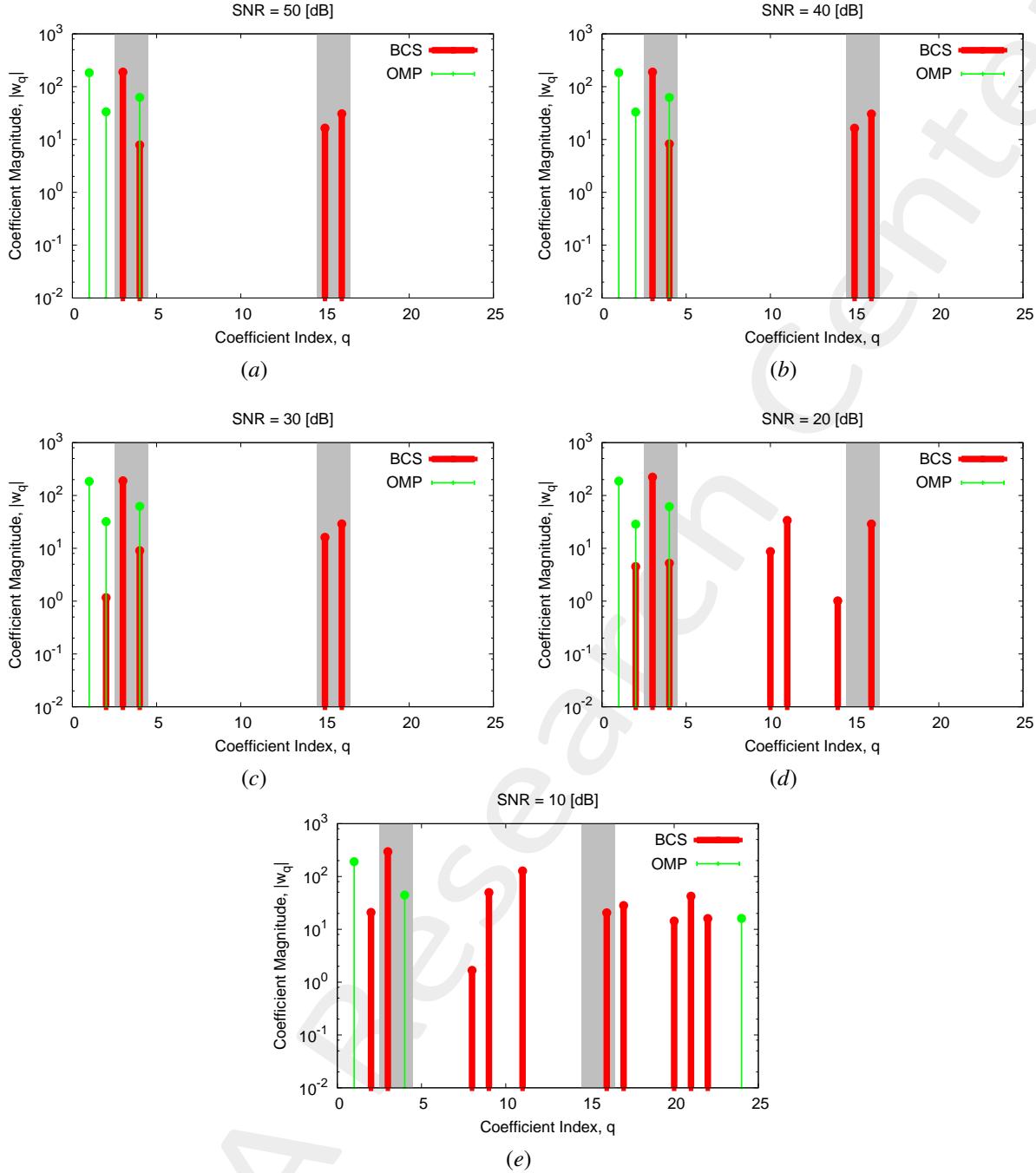


Figure 21: Coefficient comparison between original (OMP) and alternative (BCS) MbD : (a)  $SNR = 50 [dB]$ , (b)  $SNR = 40 [dB]$ , (c)  $SNR = 30 [dB]$ , (d)  $SNR = 20 [dB]$ , (e)  $SNR = 10 [dB]$

## Observations

The considered *AUT* is characterized by an excitation magnitude and phase of the second subarray (i.e.,  $\nu^{(2)} = 0.43$  and  $\gamma^{(2)} = \frac{\pi}{3} [rad]$ ):

- the *OMP* solver, except at  $SNR = 10 [dB]$ , always selects the same three vectors corresponding to magnitude failures but just one of them is associated to the magnitude failure actually affecting the *AUT*.
- the *BCS* algorithm is able to identify both the failures affecting the *AUT* even if the failure detections are not precise at low *SNRs* since the method selects also vectors not connected to the actual failures and it doesn't pick

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all the vectors of the failures affecting the *AUT*. In particular, the *BCS* correctly identify both the failures affecting the *AUT* starting from  $SNR = 40 [dB]$ .

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## Computational times

- $\Delta t_{Sim}$ : Time required to simulate the  $K$  AUT configurations used to build the  $(T \times K)$  "pattern matrix";
- $\Delta t_{SVD}$ : Time required to perform the SVD of the  $(T \times K)$  "pattern matrix";
- $\Delta t_{MbE}^{OMP/BCS}$ : (Mean) Time required by the Measurement-by-Example tool to read the SVD output and perform the estimation of the AUT radiated field.

$\Delta t_{Sim}$ [sec]	$4.72 \times 10^4$
$\Delta t_{SVD}$ [sec]	$1.79 \times 10^2$
$\Delta t_{MbE}^{BCS}$ [sec]	$3.14 \times 10^{-1}$
$\Delta t_{MbE}^{OMP}$ [sec]	$2.11 \times 10^{-3}$

Table VII: Computational times

## Remarks

- Given that the number of simulated AUTs is  $K = S \times (F^{(s)} + P^{(s)}) = 84$ , the average per-AUT simulation time is

$$\Delta t_{FEKO} \simeq \frac{\Delta t_{Sim}}{K} = \frac{4.72 \times 10^4}{84} [\text{sec}] = 5.62 \times 10^2 [\text{sec}]$$

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More information on the topics of this document can be found in the following list of references.

## References

- [1] M. Salucci, N. Anselmi, M. D. Migliore and A. Massa, "A bayesian compressive sensing approach to robust near-field antenna characterization," *IEEE Trans. Antennas Propag.*, vol. 70, no. 9, pp. 8671-8676, Sep. 2022 (DOI: 10.1109/TAP.2022.3177528).
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